Notice of References Cited

Application/Control No.

O9/888,707

Examiner

Quang N. Nguyen

Applicant(s)/Patent Under
Reexamination
TRACE ET AL.

Art Unit
Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0161872	10-2002	Pontoppidan et al.	709/223
	В	US-6,810,411	10-2004	Coughlin et al.	709/224
	С	US-5,777,989	07-1998	McGarvey, John Ryan	709/249
	D	US-6,081,900	06-2000	Subramaniam et al.	709/245
	Е	US-6,128,664	10-2000	Yanagidate et al.	709/228
	F	US-6,263,364	07-2001	Najork et al.	709/217
	G	US-2001/0006523	07-2001	Kriens, Peter	370/401
	Н	US-2001/0052016	12-2001	Skene et al.	709/226
	1	US-2002/0083342	06-2002	Webb et al.	709/217
	J	US-2002/0078206	06-2002	Boies et al.	709/226
	к	US-2002/0103931	08-2002	Mott, Charles J.	709/245
	L	US-2002/0152322	10-2002	Hay, Russell C.	709/245
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					·
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.